DV: Device S: Sensors AST: Acquisition start time AET: Acquisition end time SF: Sampling frequency MU MU: Unit of measurement DT DT: Delta time between data points PT: Post time MAC: Machine MOD: Sensor's model LOC: Sensor's location DATA KPI: Key performance indicator RMS MAC Time VAR AET MOD AST LOC DV . . . KPI PT AI 1 SF Frequency S AI 2